

Search Notes

Application/Control No.

09/996,120

Examiner

Edna Wong

Applicant(s)/Patent under
Reexamination

CHAN ET AL.

Art Unit

1795

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 568 | 959 | 6/16/2006 | EW |
| 205 | 343 | 6/16/2006 | EW |
| 205 | 427 | 6/16/2006 | EW |
| 205 | 455 | 6/16/2006 | EW |
| 205 | 293 | 6/16/2006 | EW |
| 204 | 403.1 | 6/16/2006 | EW |
| 429 | 218.1 | 6/16/2006 | EW |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|-----------------|------------|------|
| Inventor Search | 6/16/2006 | EW |
| EAST | 6/16/2006 | EW |
| Search Updated | 12/29/2006 | EW |
| EAST | 12/29/2006 | EW |
| Search Updated | 3/29/2007 | EW |
| STN | 3/29/2007 | EW |
| Search Updated | 6/2/2007 | EW |
| Search Updated | 12/26/2007 | EW |